Application/Control No. Applicant(s)/Patent Under Reexamination 10/045,354 HUI ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2823 Khiem D Nguyen **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY * 12-2000 Cheng et al. 438/424 US-6,159,821 Α * 438/424 US-5,998,278 12-1999 Yu, Simon Yeou-Chong В * US-5,270,265 12-1993 Hemmenway et al. 438/404 С US-D US-Ε F US-US-G Н US-US-US-J US-Κ US-L US-М FOREIGN PATENT DOCUMENTS Document Number Country Code-Number-Kind Code Date Classification Name Country MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

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